

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10774948	ASTROM ET AL.
	Examiner	Art Unit
	Tsai, Tsung-Yin	2609

SEARCHED

Class	Subclass	Date	Examiner
382	141 with text	3/22/2010	TYT

SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	3/22/2010	TYT
Inventor Search	3/22/2010	TYT
Classification Search with text	3/22/2010	TYT
Google Patent	3/22/2010	TYT
Google Scholar	3/22/2010	TYT
QEM	3/22/2010	TYT
IDS and Given english NPL	3/22/2010	TYT
IEEE	3/22/2010	TYT
Matthew Bella (SPE 2624)- consulted on meaning of scattering and reflective light	3/22/2010	TYT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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